

-30V P-Channel Enhancement Mode MOSFET

Description

The AP7P03MI uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

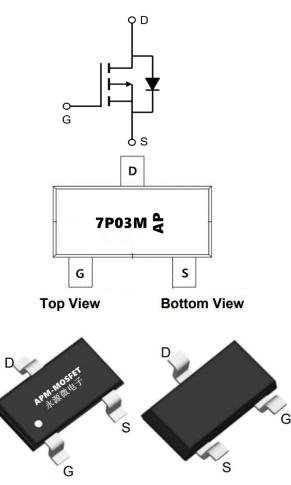
V_{DS} = -30V I_D =7.0A

 $R_{DS(ON)} < 32m\Omega @ V_{GS}=10V$ (Type: 26m Ω)

Application

Boost driver

Brushless motor



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP7P03MI	SOT23-3L	7P03M AP	3000

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-30	V
VGS	Gate-Source Voltage	±20	V
I ⊳@Tc=25 ℃	Continuous Drain Current, V _{GS} @ -4.5V ¹	-7.0	А
I ⊳@Tc=70 ℃	Continuous Drain Current, V _{GS} @ -4.5V ¹	-4.5	A
IDM	Pulsed Drain Current ²	-28	A
P₀@Tc=25℃	Total Power Dissipation ³	1.8	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R₀JA	Thermal Resistance Junction-Ambient ¹	125	°C/W
R₀JC	Thermal Resistance Junction-Case ¹	110	°C/W



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Electrical Characteristics (Tc=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30	-33		V
	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-7A		25	32	mΩ
RDS(ON)		V _{GS} =-4.5V , I _D =-5A		33	45	
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250uA	-1.0	-1.5	-2.5	V
IDSS	Drain-Source Leakage Current	$V_{\text{DS}}\text{=-24V}$, $V_{\text{GS}}\text{=}0\text{V}$, $T_{\text{J}}\text{=}25^\circ\!\!\mathbb{C}$			1	uA
ibee		$V_{\text{DS}}\text{=-}24V$, $V_{\text{GS}}\text{=}0V$, $T_{\text{J}}\text{=}55^\circ\!\!\mathbb{C}$			5	
IGSS	Gate-Source Leakage Current	V_{GS} =±20V , V_{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-7A		15		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		15	30	Ω
Qg	Total Gate Charge (-4.5V)			9.8		
Qgs	Gate-Source Charge	$V_{\text{DS}}\text{=-20V}$, $V_{\text{GS}}\text{=-4.5V}$, $I_{\text{D}}\text{=-7A}$		2.2		nC
Qgd	Gate-Drain Charge			3.4		
Td(on)	Turn-On Delay Time			16.4		
Tr	Rise Time	V_{DD} =-15V V_{GS} =-10V R_{G} =3.3 Ω		20.2		
Td(off)	Turn-Off Delay Time	I₀=-5A		55		ns
T _f	Fall Time			10		
Ciss	Input Capacitance			930		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		148		pF
Crss	Reverse Transfer Capacitance			115		
IS	Continuous Source Current ^{1,5}	$V_G=V_D=0V$, Force Current			-8	Α
VSD	Diode Forward Voltage ²	$V_{GS}\text{=}0V$, $I_{S}\text{=}\text{-}1A$, $T_{J}\text{=}25^{\circ}\!\mathrm{C}$			-1.2	V

Note :

1. The data tested by surface mo unted on a 1 inch² FR-4 board with 2OZ copper.

2、The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

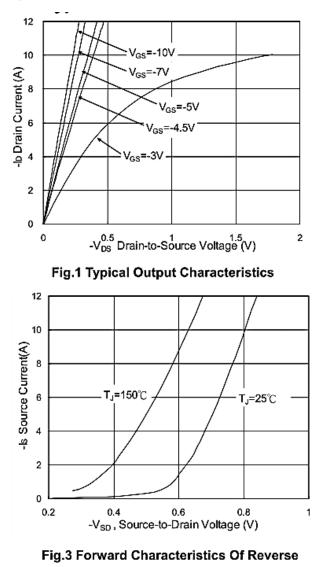
3 The power dissipation is limited by 150° C junction temperature

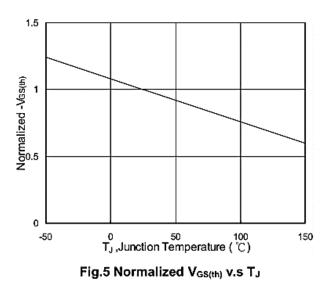
4 \sim The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.



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Typical Characteristics





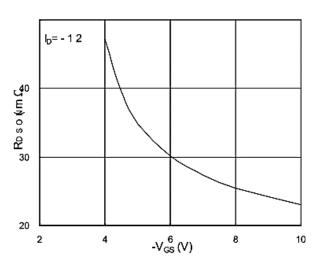


Fig.2 On-Resistance v.s Gate-Source

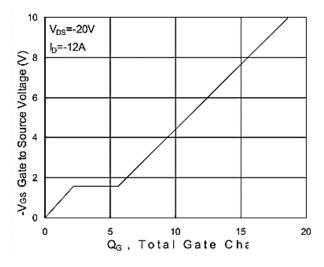
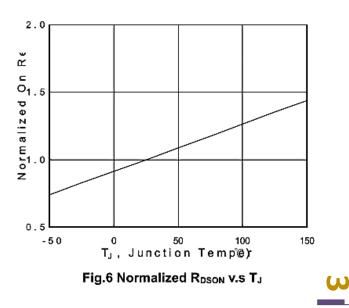


Fig.4 Gate-Charge Characteristics





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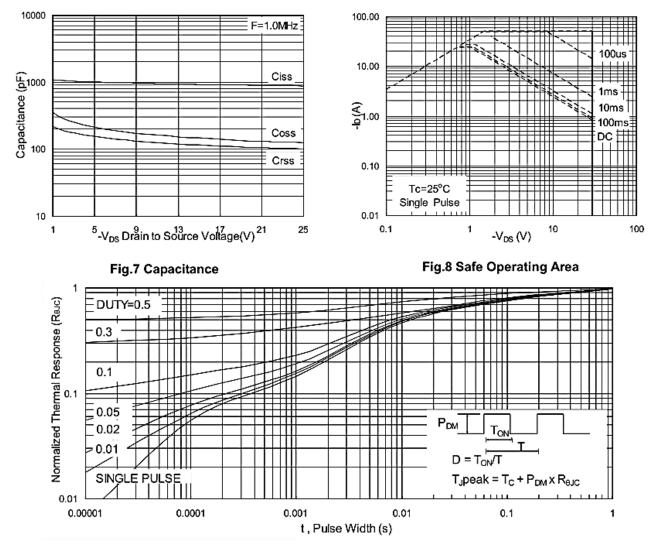


Fig.9 Normalized Maximum Transient Thermal Impedance

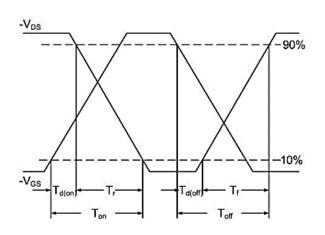
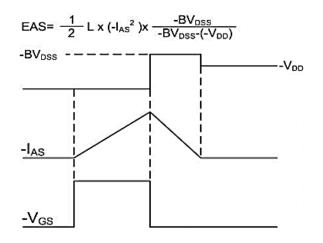


Fig.10 Switching Time Waveform

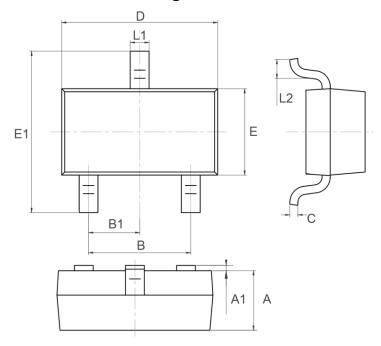






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Package Mechanical Data-SOT23-3L-Single



Symbol	Dim in mm			
	Min	Тур	Мах	
A	1	1.1	1.2	
A1	0	0.05	0.1	
В	1.8	1.9	2	
B1	0.95TYP			
С	0.1	0.15	0.2	
D	2.82	2.92	3.02	
E	1.5	1.6	1.7	
E1	2.65	2.8	2.95	
L1	0.3	0.4	0.5	
L2	0.3	0.45	0.6	



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Edition	Date	Change
REV1.0	2023/12/30	Initial release

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